

**Search Notes**

Application/Control No.

10/059,014

Examiner

Ted M. Wang

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	326	12/8/2007	TW
	UPDATED		
375	354, 359	12/8/2007	TW
375	364, 376	12/8/2007	TW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	354	12/8/2007	TW
375	326, 359	12/8/2007	TW
375	364, 376	12/8/2007	TW

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	12/8/2007	TW
ODP - searched and reviewed.	12/8/2007	TW
Inventor search - ((Chong with Lee) or (Ramanand with Venkata))	12/8/2007	TW
IEEEExplor - Author-Lee C. or Venkata R.	12/8/2007	TW
IEEE - Advance search - (CDR or (clock data recovery)) and reference clock and synchronization	12/8/2007	TW
IEEE - Advance search - (CDR or (clock data recover*)) and reference clock and phase shift*	12/8/2007	TW
Google- (CDR or (clock data recover*)) and reference clock and synchroniz* and phase shift*	12/8/2007	TW